Search Notes		

Application/Control No.

Applicant(s)/Patent under Reexamination

BELCHER, WAYNE
Art Unit

Examiner Emmanuel S. Luk

10/774,976

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SEARCHED				
Class	Subclass	Date	Examiner	
425	458	4/29/2006	EL	
15	105.5	4/29/2006	EL	
15	236.01	4/29/2006	EL	
15	236.07	4/29/2006	EL	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST text search	4/29/2006	EL	
updated EAST text search	10/2/2006	EL	
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